

3-Ethoxy-7-methoxycarbonyl-4-phenyltricyclo[4.2.1.0^{2,5}]non-3-ene

Marcel Schlaf,* Robert W. Jordan and William Tam

Department of Chemistry and Biochemistry,
University of Guelph, Guelph, Ontario,
Canada N1G 2W1

Correspondence e-mail: mschlaf@uoguelph.ca

Key indicators

Single-crystal X-ray study
T = 298 K
Mean $\sigma(\text{C}-\text{C}) = 0.003 \text{ \AA}$
Disorder in main residue
R factor = 0.043
wR factor = 0.120
Data-to-parameter ratio = 17.8

For details of how these key indicators were automatically derived from the article, see <http://journals.iucr.org/e>.

The regio- and stereochemistry of the title compound, $\text{C}_{20}\text{H}_{22}\text{O}_4$, has been established by X-ray analysis. The molecular dimensions are normal.

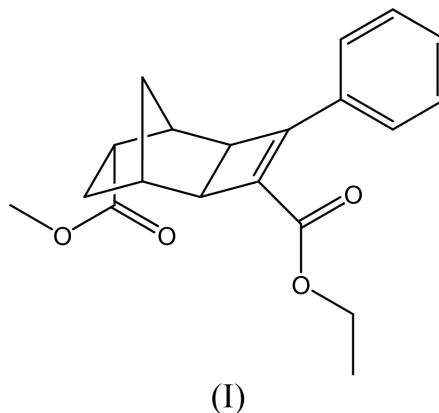
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Comment

Recently, we reported the first examples of remote substituent effects on ruthenium-catalyzed [2+2] cycloaddition reactions between 2-substituted 5-norbornenes and unsymmetrically substituted alkynes (Jordan & Tam, 2000). Four different regio- and stereoisomers could be formed in the cycloadditions. When the substituent of the norbornene was an *endo* COOMe group, two regioisomers were obtained in a ratio of 2:1. These regioisomers were separated by fractional recrystallization. The regio- and stereochemistry of the major isomer, (I), was established by single-crystal X-ray diffraction analysis.



Experimental

Addition of *endo*-2-methoxycarbonyl-5-norbornene and ethyl 3-phenylpropiolate to $\text{Cp}^*\text{RuCl}(\text{COD})$ (COD is 1,4-cyclooctadiene) in thf at 298 K yielded two regioisomers in a ratio of 2:1. Fractional recrystallization in an ethyl acetate/hexanes (1:4) mixture afforded the major regioisomer, (I). Suitable crystals were grown from an ethyl acetate/hexanes (1:4) mixture.

Crystal data

$\text{C}_{20}\text{H}_{22}\text{O}_4$
 $M_r = 326.38$
Monoclinic, $P2_1/c$
 $a = 12.842 (8) \text{ \AA}$
 $b = 9.831 (8) \text{ \AA}$
 $c = 18.063 (6) \text{ \AA}$
 $\beta = 131.44 (2)^\circ$
 $V = 1709.5 (18) \text{ \AA}^3$
 $Z = 4$

$D_x = 1.268 \text{ Mg m}^{-3}$
Mo $K\alpha$ radiation
Cell parameters from 25 reflections
 $\theta = 9.4\text{--}12.1^\circ$
 $\mu = 0.09 \text{ mm}^{-1}$
 $T = 298 (2) \text{ K}$
Block, colourless
 $0.4 \times 0.3 \times 0.2 \text{ mm}$

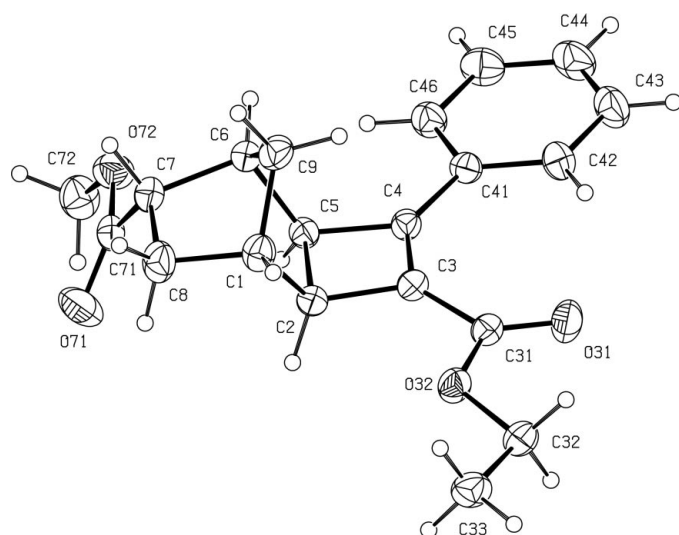


Figure 1
A view of (I). Displacement ellipsoids are drawn at the 30% probability level.

Data collection

Enraf–Nonius CAD-4
diffractometer
 $\theta/2\theta$ scans
4180 measured reflections
3909 independent reflections
2433 reflections with $I > 2\sigma(I)$
 $R_{\text{int}} = 0.010$

$\theta_{\text{max}} = 27.5^\circ$
 $h = -16 \rightarrow 16$
 $k = -12 \rightarrow 0$
 $l = -23 \rightarrow 15$
3 standard reflections
frequency: 120 min
intensity decay: none

Refinement

Refinement on F^2
 $R[F^2 > 2\sigma(F^2)] = 0.043$
 $wR(F^2) = 0.121$
 $S = 1.00$
3909 reflections
220 parameters
H-atom parameters constrained

$w = 1/[\sigma^2(F_o^2) + (0.0662P)^2]$
where $P = (F_o^2 + 2F_c^2)/3$
 $(\Delta/\sigma)_{\text{max}} < 0.001$
 $\Delta\rho_{\text{max}} = 0.22 \text{ e } \text{\AA}^{-3}$
 $\Delta\rho_{\text{min}} = -0.17 \text{ e } \text{\AA}^{-3}$
Extinction correction: *SHELXL97*
Extinction coefficient: 0.0112 (16)

The H atoms were all located in difference maps and were refined as riding atoms (C–H 0.93–0.98 Å). The methyl H atoms on C72 were obviously disordered and these were modelled as six half-occupancy H atoms spaced at 60° intervals. The methyl H atoms on C33 were not disordered and were allowed to rotate freely around the C–C bond.

Data collection: *CAD-4-PC Software* (Enraf–Nonius, 1992); cell refinement: *CAD-4-PC Software*; data reduction: *HELINA/PLATON/System S* (Spek, 2001); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *PLATON*; software used to prepare material for publication: *SHELXL97*.

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References

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